	Type	L #	Hits	Search Text	DBs
1	BRS	L1	13119 8	(determin$5 or detect$5 or measur$5 or identif$5 or inspect$5 or test$5 or recognit$5) near6 (defect$2 or deform$6 or bubble$2 or irregular$5 or (foreign near2 particle$2))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
2	BRS	L2	2364	((chang$5 or vary$5 or modif$5 or mask$5 or alter$5 or shift$5) near8 (light or beam)) with ((chang$5 or vary$5 or modif$5 or alter$5 or shift$5) near6 (angle near3 reflect$5))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
3	BRS	L3	111	1 and 2 and @ad<=20000205	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
4	BRS	L4	54	((filter$5 or reduc$5 or shad$5) near8 (reflect$5 near3 (light or beam))) with ((chang$5 or vary$5 or modif$5 or alter$5 or shift$5) near6 (angle near3 reflect$5))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
5	BRS	L5	3	1 and 4 and @ad<=20000205	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
6	BRS	L6	112	((chang$5 or vary$5 or modif$5 or mask$5 or alter$5 or shift$5) near8 (light or beam)) with ((chang$5 or vary$5 or modif$5 or alter$5 or shift$5) near9 ((axis near3 reflect$5) and (angle near3 reflect$5)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
7	BRS	L7	5	1 and 6 and @ad<=20000205	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
8	BRS	L8	2368	4 or 2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
9	BRS	L9	244	8 and (optics$3 near3 (disk or disc or carrier or medium)) and @ad<=20000205	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
10	BRS	L10	9	1 and 9	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB